Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/901,295	YANO ET AL.	
Examiner	Art Unit	
Stenhen M. Baker	2133	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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